Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/623,981	CHEN, SHUN-MIN	
Examiner	Art Unit	_
Peter R. Brown	3636	

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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